

OK TO ENTER: /T.N./

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re Application)	<u>PATENT APPLICATION</u>
)	
Inventors:	Ware, et al.)
)	Art Unit: 2829
Application No.:	10/768,443)
)	
Filed Date:	January 30, 2004)
)	Examiner: Nguyen, Trung Q.
Title:	METHOD AND APPARATUS FOR TEST AND CHARACTERIZATION OF SEMICONDUCTOR COMPONENTS)
)	<u>Customer No.: 38456</u>
)	

AMENDMENT UNDER 37 C.F.R. § 1.312(a)

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

This AMENDMENT is made after the Notice of Allowance under 37 C.F.R. § 1.312.

AMENDMENTS to the CLAIMS begin on Page 2 of this paper.

REMARKS begin on Page 5 of this paper.